

# SEMiX® 3s

### Trench IGBT Modules

#### SEMiX453GB12E4s

#### **Features**

- · Homogeneous Si
- Trench = Trenchgate technology
- V<sub>CE(sat)</sub> with positive temperature coefficient
- High short circuit capability
- UL recognized, file no. E63532

### Typical Applications\*

- AC inverter drives
- UPS
- Electronic Welding

#### **Remarks**

- Case temperature limited to T<sub>C</sub>=125°C max.
- Product reliability results are valid for T<sub>j</sub>=150°C
- Dynamic values apply to the following combination of resistors:

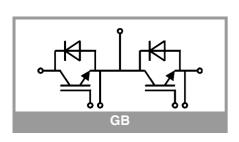
 $R_{Gon,main} = 1.0 \Omega$ 

 $R_{Goff,main} = 1.0 \Omega$ 

 $R_{G,X} = 2.2 \Omega$ 

 $R_{E,X} = 0.5 \Omega$ 

 For storage and case temperature with TIM see document "TP(\*) SEMiX 3s"



| Absolute Maximum Ratings |   |                         |         |      |  |  |  |
|--------------------------|---|-------------------------|---------|------|--|--|--|
| Symbol                   | Conditions  |                         | Values  | Unit |  |  |  |
| IGBT                     |   |                         |         |      |  |  |  |
| V <sub>CES</sub>         | T <sub>j</sub> = 25 °C  |                         | 1200    | V    |  |  |  |
| Ic                       | T <sub>j</sub> = 175 °C   | T <sub>c</sub> = 25 °C  | 683     | А    |  |  |  |
|                          |   | T <sub>c</sub> = 80 °C  | 526     | А    |  |  |  |
| I <sub>Cnom</sub>        |   |                         | 450     | Α    |  |  |  |
| I <sub>CRM</sub>         | $I_{CRM} = 3xI_{Cnom}$  |                         | 1350    | Α    |  |  |  |
| $V_{GES}$                |   |                         | -20 20  | V    |  |  |  |
| t <sub>psc</sub>         | $V_{CC} = 800 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 1200 \text{ V}$ | T <sub>j</sub> = 150 °C | 10      | μs   |  |  |  |
| T <sub>j</sub>           |   |                         | -40 175 | °C   |  |  |  |
| Inverse di               | iode  |                         |         |      |  |  |  |
| $V_{RRM}$                | T <sub>j</sub> = 25 °C  |                         | 1200    | V    |  |  |  |
| I <sub>F</sub>           | T <sub>j</sub> = 175 °C   | T <sub>c</sub> = 25 °C  | 544     | Α    |  |  |  |
|                          |   | T <sub>c</sub> = 80 °C  | 407     | Α    |  |  |  |
| I <sub>Fnom</sub>        |   |                         | 450     | Α    |  |  |  |
| I <sub>FRM</sub>         | I <sub>FRM</sub> = 3xI <sub>Fnom</sub>  |                         | 1350    | Α    |  |  |  |
| I <sub>FSM</sub>         | t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C                        |                         | 2430    | Α    |  |  |  |
| Tj                       |   |                         | -40 175 | °C   |  |  |  |
| Module                   |   |                         |         |      |  |  |  |
| I <sub>t(RMS)</sub>      |   |                         | 600     | Α    |  |  |  |
| T <sub>stg</sub>         | module without TIM  |                         | -40 125 | °C   |  |  |  |
| V <sub>isol</sub>        | AC sinus 50Hz, t =  | 1 min                   | 4000    | V    |  |  |  |

| Characteristics   |   |                              |      |       |       |      |  |
|---|---|------------------------------|------|-------|-------|------|--|
| Symbol  | Conditions  |                              | min. | typ.  | max.  | Unit |  |
| IGBT  |   |                              |      |       |       |      |  |
| $\begin{array}{c c} V_{CE(sat)} & I_{C} = 450 \text{ A} \\ V_{GE} = 15 \text{ V} \\ \text{chiplevel} \end{array}$ | •   | T <sub>j</sub> = 25 °C       |      | 1.80  | 2.05  | V    |  |
|   | T <sub>j</sub> = 150 °C   |                              | 2.19 | 2.40  | V     |      |  |
| V <sub>CE0</sub>  | chiplevel   | T <sub>j</sub> = 25 °C       |      | 8.0   | 0.9   | V    |  |
|   |   | T <sub>j</sub> = 150 °C      |      | 0.7   | 8.0   | V    |  |
|   | V <sub>GE</sub> = 15 V  | T <sub>j</sub> = 25 °C       |      | 2.2   | 2.6   | mΩ   |  |
|   | chiplevel   | T <sub>j</sub> = 150 °C      |      | 3.3   | 3.6   | mΩ   |  |
| $V_{GE(th)}$  | $V_{GE}=V_{CE}$ , $I_{C}=18$ m  | A                            | 5    | 5.8   | 6.5   | V    |  |
| I <sub>CES</sub>  | $V_{GE} = 0 \text{ V}, V_{CE} = 12$   | 00 V, T <sub>j</sub> = 25 °C |      |       | 5     | mA   |  |
| C <sub>ies</sub>  | V 05.V  | f = 1 MHz                    |      | 27.9  |       | nF   |  |
| Coes  | $V_{CE} = 25 \text{ V}$<br>$V_{GF} = 0 \text{ V}$                           | f = 1 MHz                    |      | 1.74  |       | nF   |  |
| C <sub>res</sub>  | V GE = U V  | f = 1 MHz                    |      | 1.53  |       | nF   |  |
| $Q_{G}$   | V <sub>GE</sub> = - 8 V+ 15 V   |                              |      | 2550  |       | nC   |  |
| R <sub>Gint</sub>   | T <sub>j</sub> = 25 °C  |                              |      | 1.7   |       | Ω    |  |
| t <sub>d(on)</sub>  | $I_C = 450 \text{ A}$ $V_{GE} = +15/-15 \text{ V}$ $R_{G, op} = 1.9 \Omega$ | T <sub>j</sub> = 150 °C      |      | 336   |       | ns   |  |
| t <sub>r</sub>  |   | T <sub>j</sub> = 150 °C      |      | 80    |       | ns   |  |
| E <sub>on</sub>   |   | T <sub>j</sub> = 150 °C      |      | 45    |       | mJ   |  |
| t <sub>d(off)</sub>   |   | T <sub>j</sub> = 150 °C      |      | 615   |       | ns   |  |
| t <sub>f</sub>  |   | T <sub>j</sub> = 150 °C      |      | 130   |       | ns   |  |
| E <sub>off</sub>  |   | T <sub>j</sub> = 150 °C      |      | 66.5  |       | mJ   |  |
| R <sub>th(j-c)</sub>  | per IGBT  |                              |      |       | 0.065 | K/W  |  |
| R <sub>th(c-s)</sub>  | per IGBT (λ <sub>grease</sub> =0.81 W/(m*K))                                |                              |      | 0.03  |       | K/W  |  |
| R <sub>th(c-s)</sub>  | per IGBT, pre-applied phase change material                                 |                              |      | 0.021 |       | K/W  |  |



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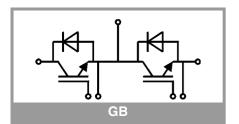
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| Characte              | ristics  |                         |      |             |      |           |
|-----------------------|--|-------------------------|------|-------------|------|-----------|
| Symbol                | Conditions   |                         | min. | typ.        | max. | Unit      |
| Inverse d             | iode   |                         |      |             |      |           |
| $V_F = V_{EC}$        | I <sub>F</sub> = 450 A   | T <sub>j</sub> = 25 °C  |      | 2.14        | 2.46 | V         |
|                       | V <sub>GE</sub> = 0 V<br>chiplevel   | T <sub>j</sub> = 150 °C |      | 2.07        | 2.38 | V         |
| V <sub>F0</sub>       | chiplevel  | T <sub>j</sub> = 25 °C  |      | 1.30        | 1.50 | V         |
|                       |  | T <sub>j</sub> = 150 °C |      | 0.90        | 1.10 | V         |
| r <sub>F</sub>        | chiplevel  | T <sub>j</sub> = 25 °C  |      | 1.87        | 2.1  | $m\Omega$ |
|                       |  | T <sub>j</sub> = 150 °C |      | 2.6         | 2.8  | mΩ        |
| I <sub>RRM</sub>      | $I_F = 450 \text{ A}$<br>di/dt <sub>off</sub> = 5000 A/µs  | T <sub>j</sub> = 150 °C |      | 350         |      | Α         |
| Q <sub>rr</sub>       |  | T <sub>j</sub> = 150 °C |      | 70          |      | μC        |
| E <sub>rr</sub>       | V <sub>GE</sub> = -15 V<br>V <sub>CC</sub> = 600 V   | T <sub>j</sub> = 150 °C |      | 28          |      | mJ        |
| R <sub>th(j-c)</sub>  | per diode  |                         |      |             | 0.11 | K/W       |
| R <sub>th(c-s)</sub>  | per diode (λ <sub>grease</sub> =0.81 W/(m*K))  |                         |      | 0.045       |      | K/W       |
| R <sub>th(c-s)</sub>  | per diode, pre-applied phase change material   |                         |      | 0.036       |      | K/W       |
| Module                | •  |                         |      |             |      | •         |
| L <sub>CE</sub>       |  |                         |      | 20          |      | nΗ        |
| R <sub>CC'+EE'</sub>  | measured per   | T <sub>C</sub> = 25 °C  |      | 0.7         |      | mΩ        |
|                       | switch   | T <sub>C</sub> = 125 °C |      | 1           |      | mΩ        |
| Rth <sub>(c-s)1</sub> | calculated without thermal coupling  |                         |      | 0.009       |      | K/W       |
| Rth <sub>(c-s)2</sub> | including thermal coupling, Ts underneath module $(\lambda_{grease}=0.81 \text{ W/} (\text{m*K}))$ |                         |      | 0.013       |      | K/W       |
| Rth <sub>(c-s)2</sub> | including thermal coupling, Ts underneath module, pre-applied phase change material                |                         |      | 0.01        |      | K/W       |
| Ms                    | to heat sink (M5)  |                         | 3    |             | 5    | Nm        |
| Mt                    |  | to terminals (M6)       | 2.5  |             | 5    | Nm        |
|                       | ]  |                         |      |             |      | Nm        |
| W                     |  | ,                       |      |             | 300  | g         |
| Temperat              | ure Sensor   |                         |      |             |      |           |
| R <sub>100</sub>      | $T_c$ =100°C ( $R_{25}$ =5 k $\Omega$ )  |                         |      | 493 ± 5%    |      | Ω         |
| B <sub>100/125</sub>  | $R_{(T)} = R_{100} exp[B_{100/125}(1/T-1/T_{100})]; T[K];$   |                         |      | 3550<br>±2% |      | К         |



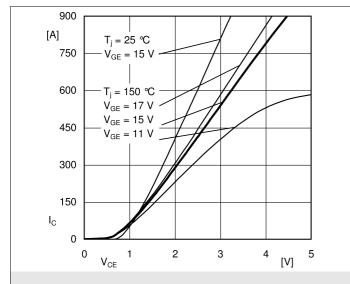


Fig. 1: Typ. output characteristic, inclusive  $R_{CC'+\; EE'}$ 

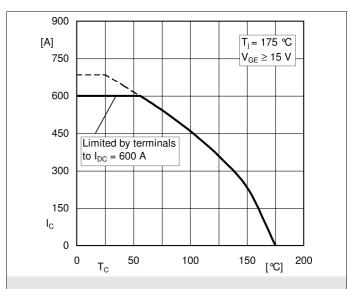


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$ 

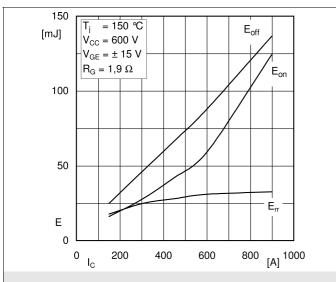


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$ 

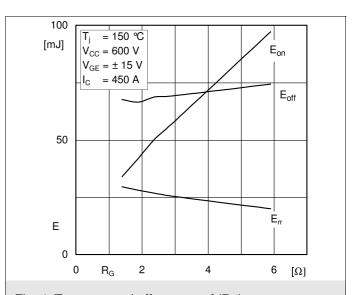


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$ 

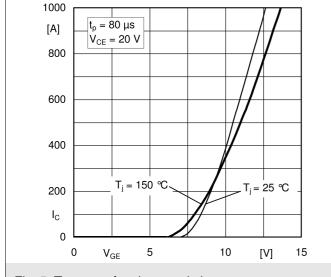


Fig. 5: Typ. transfer characteristic

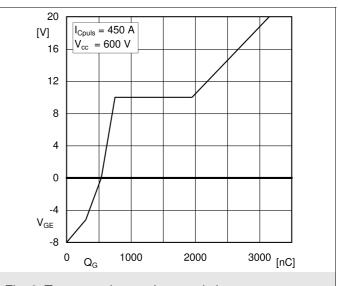
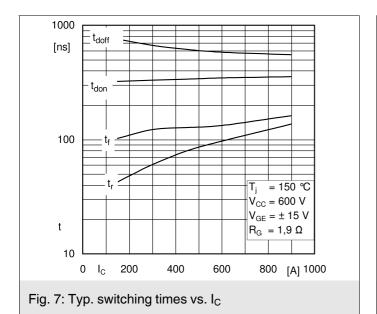


Fig. 6: Typ. gate charge characteristic



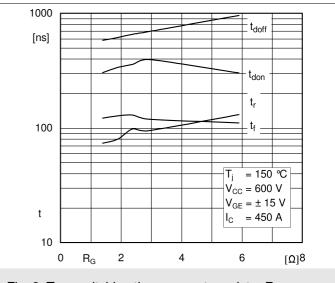


Fig. 8: Typ. switching times vs. gate resistor R<sub>G</sub>

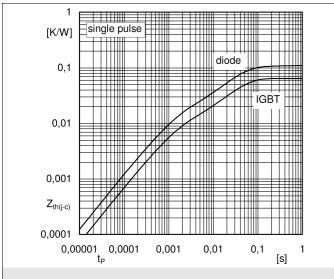


Fig. 9: Transient thermal impedance

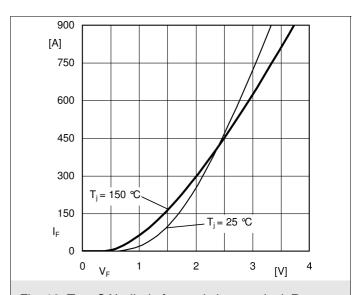


Fig. 10: Typ. CAL diode forward charact., incl. R<sub>CC'+ EE'</sub>

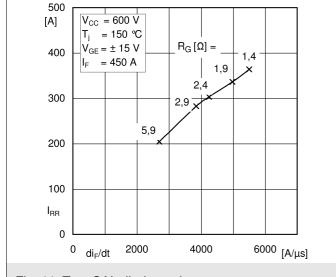


Fig. 11: Typ. CAL diode peak reverse recovery current

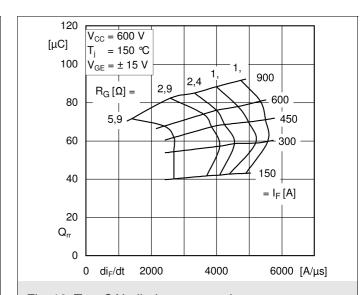
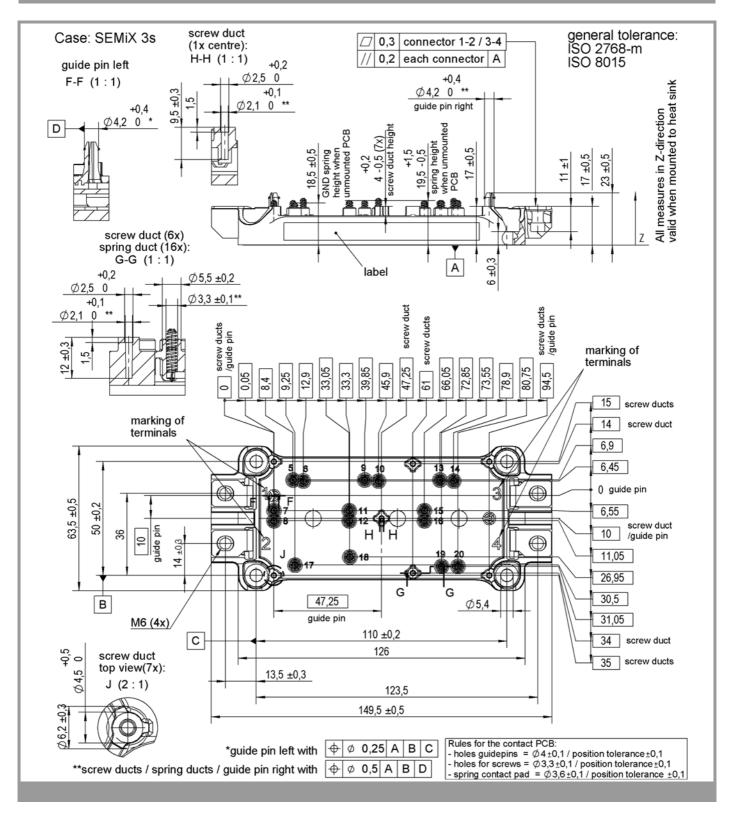
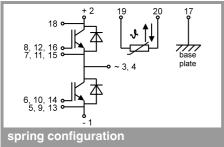


Fig. 12: Typ. CAL diode recovery charge





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

#### \*IMPORTANT INFORMATION AND WARNINGS

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